

Notice of References Cited	Application/Control No. 10/825,007		Applicant(s)/Patent Under Reexamination BERG ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,412,071 B1	06-2002	Hollander et al.	713/200
*	B	US-6,832,302 B1	12-2004	Fetzer et al.	717/127
*	C	US-2003/0172293 A1	09-2003	Johnson et al.	713/200
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	Brian V. Chess, "Improving Computer Security Using Extended Static Checking," Proceedings of the IEEE Symposium on Security and Privacy, May 2002, (14 pages).			
	V	Eric Haugh and Matt Bishop, "Testing C Programs for Buffer Overflow Vulnerabilities," Proceedings of the 2003 Symposium on Networked and Distributed System Security (SNDSS 2003), Feb. 2003, (8 pages).			
	W	David Larochelle and David Evans, "Statically Detecting Likely Buffer Overflow Vulnerabilities," Proceedings of the 2001 USENIX Security Symposium, Aug. 2001, (13 pages).			
	X	Umesh Shankar, et al., "Detecting Format String Vulnerabilities with Type Qualifiers," Proceedings of the 10 th USENIX Security Symposium, Aug. 2001, (16 pages).			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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	U	John Viega, et al., "ITS4: A Static Vulnerability Scanner for C and C++ Code," 16 th Annual Computer Security Applications Conference, 2000, (11 pages).
	V	David Wagner, et al., "A First Step Towards Automated Detection of Buffer Overrun Vulnerabilites," Proceedings of the Network and Distributed System Security Symposium, Feb. 2000, (15 pages).
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